

Supplemental Materials

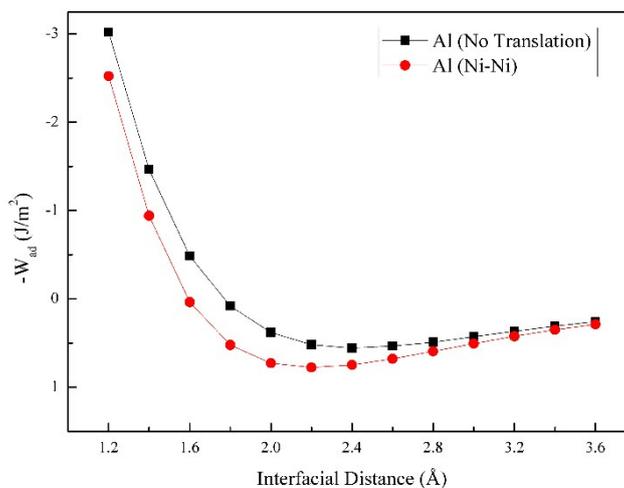


Fig. S1 (Color online): The interface adhesion curves for the Al-terminated interface as calculated within the PBE.

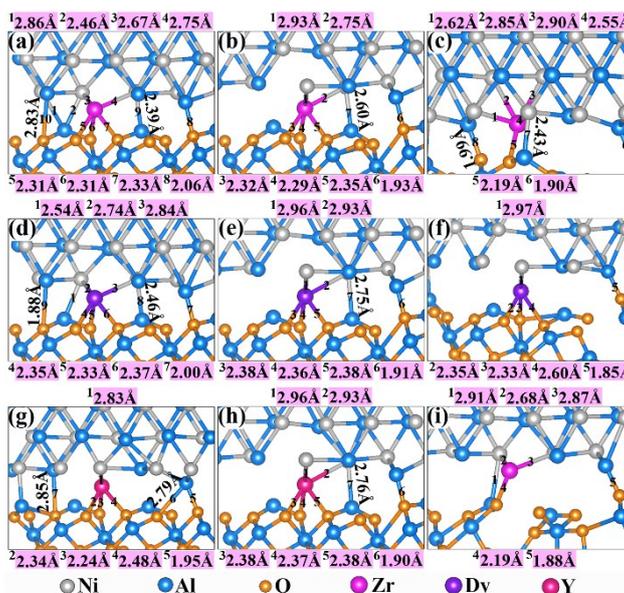


FIG. S2 (Color online): The variation of bond lengths at the interface viewed along crystallographic $[0001]_{\text{alumina}}$ direction, i.e. z axis in Cartesian coordinate system at equilibrium, at tensile strains corresponding to the maximum stress, and after instability respectively for the $\text{Al}_2\text{O}_3/\text{NiAl}$ interface of Zr-doping (a-c), Dy-doping (d-f), Y-doping (g-i).

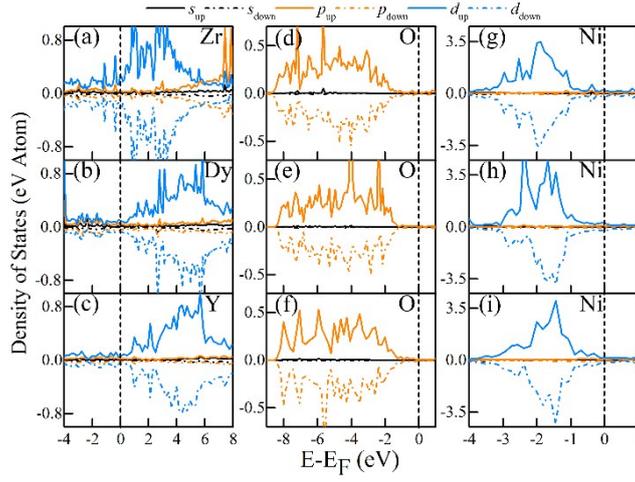


FIG. S3 (Color online): The valence charge density differences (VCDD) and Bader charges analysis for single RE doped $\text{Al}_2\text{O}_3/\text{NiAl}$ interface of (a) Zr atom, (d) O atom and (g) Ni atom in Zr-doping; (b) Dy atom, (e) O atom and (h) Ni atom in Dy-doping; (c) Y atom, (f) O atom and (i) Ni atom in Y-doping.